

# EMC TEST REPORT

**ETSI EN 301 489-1 V2.2.3 (2019-11)**  
**ETSI EN 301 489-17 V3.2.4 (2020-09)**  
**EN 55032:2015+A11:2020**  
**EN 55035:2017+A11:2020**

**Product :** Electronic Shelf Label



**Trade Mark :**



**Model Name :** MTag42R

**Family Model :** MTag42, MTag42Y, MTag42B

**Report No. :** S22061502214001

## Prepared for

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## TEST RESULT CERTIFICATION

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**Manufacturer's Name** ..... : Shenzhen Minew Technologies Co., Ltd.  
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Guiyue Road, Longhua District, Shenzhen

**Product description**

**Product name** ..... : Electronic Shelf Label



**Trademark** ..... :



**Model Name** ..... : MTag42R  
**Family Model** ..... : MTag42, MTag42Y, MTag42B  
ETSI EN 301 489-1 V2.2.3 (2019-11)  
ETSI EN 301 489-17 V3.2.4 (2020-09)  
**Standards** ..... : EN 55032:2015+A11:2020  
EN 55035:2017+A11:2020

This device described above has been tested by NTEK, and the test results show that the equipment under test (EUT) is in compliance with the article 3.1(b) of the Directive 2014/53/EU requirements. And it is applicable only to the tested sample identified in the report.

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**Test Sample Number** ..... : S220615022015

**Date of Test** .....

**Date (s) of performance of tests** ..... Jun 15, 2022 ~ Jul 11, 2022

**Date of Issue** ..... Jul 11, 2022

**Test Result** ..... Pass

**Testing Engineer** :

A handwritten signature in black ink, appearing to read "Korka Lin".  
(Korka Lin)

**Authorized Signatory** :

A handwritten signature in black ink, appearing to read "Alex".  
(Alex Li)



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## 1. TEST SUMMARY

Test procedures according to the technical standards:

ETSI EN 301 489-1 V2.2.3 (2019-11)  
ETSI EN 301 489-17 V3.2.4 (2020-09)  
EN 55032:2015+A11:2020  
EN 55035:2017+A11:2020

### EMC Emission

Standard	Test Item	Limit	Judgment	Remark
EN 55032:2015+A11:2020	Conducted Emission On AC And Telecom Port 150kHz to 30MHz	Class B	N/A	
	Disturbance Voltage at The Antenna Terminals (30MHz To 2150MHz)	-----	N/A	
	Wanted signal and disturbance voltage at the RF output terminals (30MHz To 2150MHz)	-----	N/A	
	Radiated Emission 30MHz to 1000MHz	Class B	PASS	
	Radiated Emission 1GHz to 6GHz	Class B	PASS	
EN61000-3-2:2014	Harmonic Current Emission	Class A	N/A	
EN 61000-3-3:2013	Voltage Fluctuations & Flicker	-----	N/A	

### EMC Immunity

Section EN 55035:2017+A11:2020	Test Item	Performance Criteria	Judgment	Remark
EN 61000-4-2:2009	Electrostatic Discharge	B	PASS	
EN 61000-4-3:2006+A1:2008+A2:2010	RF electromagnetic field	A	PASS	
EN 61000-4-4:2012	Fast transients	B	N/A	
EN 61000-4-5:2014+A1:2017	Surges	B	N/A	
EN 61000-4-6:2014	Continuous radio frequency disturbances or Injected Current	A	N/A	
EN 61000-4-8:2010	Power Frequency Magnetic Field	A	N/A	NOTE (3)
EN 61000-4-11:2004	Volt. Interruptions Volt. Dips	B / C / C NOTE (2)	N/A	

**NOTE:**

- (1) "N/A" denotes test is not applicable in this Test Report
- (2) Voltage dip: 100% reduction – Performance Criteria **B**  
Voltage dip: 30% reduction – Performance Criteria **C**  
Voltage Interruption: 100% Interruption – Performance Criteria **C**
- (3) Applicable only to equipment containing devices intrinsically susceptible to magnetic fields, such as CRT monitors, Hall effect elements, electro-dynamic microphones, magnetic field sensors or audio frequency transformers.
- (4) For client's request and manual description, the test will not be executed.



## 1.1 TEST FACILITY

Shenzhen NTEK Testing Technology Co., Ltd.

Add. : 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street Bao'an District, Shenzhen 518126 P.R. China

CNAS-Lab. : The Certificate Registration Number is L5516

IC-Registration : The Certificate Registration Number is CN0074

FCC- Accredited : Test Firm Registration Number: 463705  
Designation Number: CN1184

A2LA-Lab. : The Certificate Registration Number is 4298.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated 8 January 2009).

## 1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement  $y \pm U$ , where expanded uncertainty  $U$  is based on a standard uncertainty multiplied by a coverage factor of  $k=2$ , providing a level of confidence of approximately 95 %.




Test Item	Measurement Frequency Range	K	U(dB)
AC Mains Conducted Emission	0.009kHz ~ 0.15MHz	2	2.66
AC Mains Conducted Emission	0.15MH ~ 30MHz	2	2.80
Telecom Conducted Emission (Cat 3)	0.15MHz ~ 30MHz	2	2.40
Telecom Conducted Emission (Cat 5)	0.15MHz ~ 30MHz	2	2.58
Radiated Emission	30MHz ~ 1000MHz	2	2.64
Radiated Emission	1000MHz ~ 6000MHz	2	2.40
Radiated Emission	6000MHz ~ 18000MHz	2	2.52

[illegible]



## 2. GENERAL INFORMATION

### 2.1 GENERAL DESCRIPTION OF EUT

Equipment	Electronic Shelf Label
Trade Mark	  
Model Name	MTag42R
Family Model	MTag42,MTag42Y,MTag42B
Model Difference	All models are the same circuit and RF module, except the screen display color.
Frequency Bands	<input checked="" type="checkbox"/> BT: 2402~2480 MHz
Modulation Mode:	<input checked="" type="checkbox"/> BLE: GFSK
Power Rating	DC 3.0V from Battery
Adapter	N/A
Battery	DC 3.0V
Connecting I/O Port(s)	Please refer to the User's Manual
Antenna	PCB Antenna
Hard Ware Version	V1.X
Soft Ware Version	V3.X

## 2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generated from EUT, the test system was pre-scanning tested based on the consideration of following EUT operation mode or test configuration mode which possibly have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Working
Mode 2	BT

For Radiated Test	
Final Test Mode	Description
Mode 1	Working

For EMS Test	
Pretest Mode	Description
Mode 1	Working
Mode 2	BT

NOTE: The test modes were carried out for all operation modes. The final test mode of the EUT was the worst test mode for EMI, and its test data was showed.






### 2.3 DESCRIPTION OF TEST SETUP

RE

E-1  
EUT

## 2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Brand	Model/Type No.	Series No.	Note
E-1	Electronic Shelf Label	  	MTag42R	N/A	EUT

Item	Cable Type	Shielded Type	Ferrite Core	Length	Note

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in 『Length』 column.



## 2.5 MEASUREMENT INSTRUMENTS LIST

### 2.5.1 CONDUCTED EMISSION

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Test Cable	N/A	C01	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
2	Test Cable	N/A	C02	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
3	Test Cable	N/A	C03	N/A	Mar. 29, 2021	Mar. 28, 2024	3 years
4	Pulse Limiter	SCHWARZBECK	VTSD 9561F	9716	Apr. 06, 2022	Apr. 05, 2023	1 year
5	50Ω Switch	ANRITSU CORP	MP59B	6200983704	Mar. 29, 2021	Mar. 28, 2024	3 year
6	EMI Test Receiver	R&S	ESCI	101160	Apr. 06, 2022	Apr. 05, 2023	1 year
7	Universal radio communication tester	R&S	CMU200	1100.008.02	Apr. 06, 2022	Apr. 05, 2023	1 year
8	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Apr. 06, 2022	Apr. 05, 2023	1 year
9	LISN	SCHWARZBECK	NNLK 8129	8129245	Apr. 06, 2022	Apr. 05, 2023	1 year
10	LISN	R&S	ENV216	101313	Apr. 06, 2022	Apr. 05, 2023	1 year

### 2.5.2 RADIATED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Antenna Mast	EM	SC100_1	N/A	N/A	N/A	N/A
2	Turn Table	EM	SC100	060531	N/A	N/A	N/A
3	EMI Test Receiver	R&S	ESCI-7	101318	Apr. 06, 2022	Apr. 05, 2023	1 year
4	50Ω Switch	Anritsu Corp	MP59B	6200983705	Apr. 06, 2022	Apr. 05, 2023	1 year
5	Spectrum Analyzer	Agilent	E4407B	MY45108040	Apr. 01, 2022	Mar. 31, 2023	1 year
6	Universal radio communication tester	R&S	CMU200	1100.008.02	Jun 14, 2022	Jun 13, 2023	1 year
7	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun 14, 2022	Jun 13, 2023	1 year
8	Test Cable	N/A	R-01	N/A	Aug. 07, 2019	Aug. 06, 2022	3 years
9	Test Cable	N/A	R-02	N/A	Aug. 07, 2019	Aug. 06, 2022	3 years
10	Bilog Antenna	TESEQ	CBL6111D	31216	Mar. 30, 2022	Mar. 29, 2023	1 year
11	Horn Antenna	EM	EM-AH-10180	2011071402	Mar. 31, 2022	Mar. 30, 2023	1 year
12	Amplifier	EMC	EMC051835SE	980246	Apr. 01, 2022	Mar. 31, 2023	1 year

### 2.5.3 HARMONICS AND FILCK

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Harmonic & Flicker	EM TEST	DPA500	0303-04	Apr .06, 2022	Apr .05, 2023	1 year
2	AC Power Source	EM TEST	ACS500	0203-01	Apr .06, 2022	Apr .05, 2023	1 year
3	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun 14, 2022	Jun 13, 2023	1 year
4	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun 14, 2022	Jun 13, 2023	1 year

### 2.5.4 ESD

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun 14, 2022	Jun 13, 2023	1 year
2	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun 14, 2022	Jun 13, 2023	1 year
3	Electrostatic Discharge Generator	Lioncel	ESD-203B	ESD203B0 150402	Apr .06, 2022	Apr .05, 2023	1 year

### 2.5.5 RS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Unversal radio communication tester	R&S	CMU200	1100.008.0 2	Jun 14, 2022	Jun 13, 2023	1 year
2	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun 14, 2022	Jun 13, 2023	1 year
3	Audio Power Amplifier	Brüel & Kjær	4602B	2185667	Jun 14, 2022	Jun 13, 2023	1 year
4	Mouth Simulator	Brüel & Kjær	2669	2143265	Jun 14, 2022	Jun 13, 2023	1 year
5	Sound Calibrator	Brüel & Kjær	4185	2194825	Jun 14, 2022	Jun 13, 2023	1 year
6	1/2" Pressure-field Microphone	Brüel & Kjær	735	2641678	Jun 14, 2022	Jun 13, 2023	1 year
7	Telephone Test Head	Brüel & Kjær	4185	2631728	Jun 14, 2022	Jun 13, 2023	1 year
8	Audio Analyzer	R&S	UPV	100419	Jun 14, 2022	Jun 13, 2023	1 year



9	Ear Simulator for Telephonometry	Brüel & Kjær	4185	2553612	Jun 14, 2022	Jun 13, 2023	1 year
10	Bilog Antenna	ETS	3142E(Frequency range 30MHz to 6 GHz)	00214344	Jun 14, 2022	Jun 13, 2023	1 year
11	Broadband Amplifier	AR	60S1G6	0350414	Jun 14, 2022	Jun 13, 2023	1 year
12	PSG Analog Signal Generator	Agilent	MTag42R257D	MY51110112	Jun 14, 2022	Jun 13, 2023	1 year
13	Power Amplifier	rflight	NTWPA-00810200	17063153	Apr .06, 2022	Apr .05, 2023	1 year
14	Power Amplifier	AR	25S1G4A	308598	Apr .06, 2022	Apr .05, 2023	1 year
15	Power Meter	Agilent	E4419B	MY45102538	Jun 14, 2022	Jun 13, 2023	1 year
16	Power Sensor	Agilent	E9301A	MY41495644	Jun 14, 2022	Jun 13, 2023	1 year
17	Power Sensor	Agilent	E9301A	UMTag42R9212148	Jun 14, 2022	Jun 13, 2023	1 year

#### 2.5.6 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Surge Generator	EVERFINE	EMS61000-5A-V1	1101002	Jun 14, 2022	Jun 13, 2023	1 year
2	DIPS Generator	EVERFINE	EMS61000-11K	1011002	Jun 14, 2022	Jun 13, 2023	1 year
3	EFT/B Generator	EVERFINE	EMS61000-4A-V2	1012005	Jun 14, 2022	Jun 13, 2023	1 year
4	Unversal radio communication tester	R&S	CMU200	1100.008.02	Jun 14, 2022	Jun 13, 2023	1 year
5	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun 14, 2022	Jun 13, 2023	1 year

### 2.5.7 INJECTION CURRENT

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Attenuator	TESEQ	ATN 6075	38411	N/A	N/A	N/A
2	RF Cable	TESEQ	RF Cable	N/A	N/A	N/A	N/A
3	Signal Generator	R&S	SML03	100954	Apr .06, 2022	Apr .05, 2023	1 year
4	Power Amplifier	TESEQ	CBA 230M-080	T44376	Apr .06, 2022	Apr .05, 2023	1 year
5	EM Clamp	FCC	F-203I-23M M	504	Apr .06, 2022	Apr .05, 2023	1 year
6	Audio Power Amplifier	Brüel & Kjær	4602B	2185667	Jun 14, 2022	Jun 13, 2023	1 year
7	Mouth Simulator	Brüel & Kjær	2669	2143265	Jun 14, 2022	Jun 13, 2023	1 year
8	Sound Calibrator	Brüel & Kjær	4185	2194825	Jun 14, 2022	Jun 13, 2023	1 year
9	1/2" Pressure-field Microphone	Brüel & Kjær	735	2641678	Jun 14, 2022	Jun 13, 2023	1 year
10	Audio Analyzer	R&S	UPV	100419	Jun 14, 2022	Jun 13, 2023	1 year
11	Ear Simulator for Telephonometry	Brüel & Kjær	4185	2553612	Jun 14, 2022	Jun 13, 2023	1 year
12	Telephone Test Head	Brüel & Kjær	4185	2631728	Jun 14, 2022	Jun 13, 2023	1 year
13	Unversal radio communication tester	R&S	CMU200	1100.008.02	Jun 14, 2022	Jun 13, 2023	1 year
14	Wideband Radio Communication Tester Specifications	R&S	CMW500	148500	Jun 14, 2022	Jun 13, 2023	1 year
15	Coupling and Decoupling Network	TESEQ	CDN M016	38722	Apr .06, 2022	Apr .05, 2023	1 year



### 3. EMC EMISSION TEST

#### 3.1 CONDUCTED EMISSION MEASUREMENT

##### 3.1.1 POWER LINE CONDUCTED EMISSION

(Frequency Range 150kHz-30MHz)

**Table A.8 – Requirements for conducted emissions from the AC mains power ports of Class A equipment**

Applicable to				
1. AC mains power ports (3.1.1)				
Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class A limits dB(μV)
A8.1	0,15 – 0,5	AMN	Quasi Peak / 9 kHz	79
	0,5 – 30			73
A8.2	0,15 – 0,5	AMN	Average / 9 kHz	66
	0,5 – 30			60
Apply A8.1 and A8.2 across the entire frequency range.				

**Table A.9 – Requirements for conducted emissions from the AC mains power ports of Class B equipment**

Applicable to				
1. AC mains power ports (3.1.1)				
Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class B limits dB(μV)
A9.1	0,15 – 0,5	AMN	Quasi Peak / 9 kHz	66 – 56
	0,5 – 5			56
	5 – 30			60
A9.2	0,15 – 0,5	AMN	Average / 9 kHz	56 – 46
	0,5 – 5			46
	5 – 30			50

Apply A9.1 and A9.2 across the entire frequency range.

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " \* " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

### 3.1.2 TELECOMMUNICATION PORT CONDUCTED EMISSION(VOLTAGE LIMITS) (Frequency Range 150kHz-30MHz)

**Table A.10 – Requirements for asymmetric mode conducted emissions from Class A equipment**

Applicable to					
1. wired network ports (3.1.30) 2. optical fibre ports (3.1.24) with metallic shield or tension members 3. antenna ports (3.1.3)					
Table clause	Frequency range MHz	Coupling device (see Table A.7)	Detector type / bandwidth	Class A voltage limits dB(μV)	Class A current limits dB(μA)
A10.1	0,15 – 0,5	AAN	Quasi Peak / 9 kHz	97 – 87	n/a
	0,5 – 30			87	
	0,15 – 0,5	AAN	Average / 9 kHz	84 – 74	
	0,5 – 30			74	
A10.2	0,15 – 0,5	CVP and current probe	Quasi Peak / 9 kHz	97 – 87	53 – 43
	0,5 – 30			87	43
	0,15 – 0,5	CVP and current probe	Average / 9 kHz	84 – 74	40 – 30
	0,5 – 30			74	30
A10.3	0,15 – 0,5	Current Probe	Quasi Peak / 9 kHz	n/a	53 – 43
	0,5 – 30				43
	0,15 – 0,5	Current Probe	Average / 9 kHz		40 – 30
	0,5 – 30				30
The choice of coupling device and measurement procedure is defined in Annex C.					
AC mains ports that also have the function of a wired network port shall meet the limits given in Table A.8.					
The test shall cover the entire frequency range.					
The application of the voltage and/or current limits is dependent on the measurement procedure used. Refer to Table C.1 for applicability.					
Testing is required at only one EUT supply voltage and frequency.					
Applicable to ports listed above and intended to connect to cables longer than 3 m.					



**Table A.12 – Requirements for conducted differential voltage emissions from Class B equipment**

**Applicable to**

1. TV broadcast receiver tuner ports (3.1.8) with an accessible connector
2. RF modulator output ports (3.1.27)
3. FM broadcast receiver tuner ports (3.1.8) with an accessible connector

Table clause	Frequency range MHz	Detector type/ bandwidth	Class B limits dB(μV) 75 Ω			Applicability
			Other	Local Oscillator Fundamental	Local Oscillator Harmonics	
A12.1	30 – 950	For frequencies ≤1 GHz	46	46	46	See a)
	950 – 2 150		46	54	54	
A12.2	950 – 2 150	Quasi Peak/ 120 kHz	46	54	54	See b)
A12.3	30 – 300		46	54	50	See c)
	300 – 1 000				52	
A12.4	30 – 300	For frequencies ≥1 GHz	46	66	59	See d)
	300 – 1 000				52	
A12.5	30 – 950	Peak/ 1 MHz	46	76	46	See e)
	950 – 2 150			n/a	54	

a) Television receivers (analogue or digital), video recorders and PC TV broadcast receiver tuner cards working in channels between 30 MHz and 1 GHz, and digital audio receivers.

b) Tuner units (not the LNB) for satellite signal reception.

c) Frequency modulation audio receivers and PC tuner cards.

d) Frequency modulation car radios.

e) Applicable to EUTs with RF modulator output ports (for example DVD equipment, video recorders, camcorders and decoders etc.) designed to connect to TV broadcast receiver tuner ports.

Testing is required at only one EUT supply voltage and frequency.

The term 'other' refers to all emissions other than the fundamental and the harmonics of the local oscillator.

The test shall be performed with the device operating at each reception channel.

The test shall cover the entire frequency range.

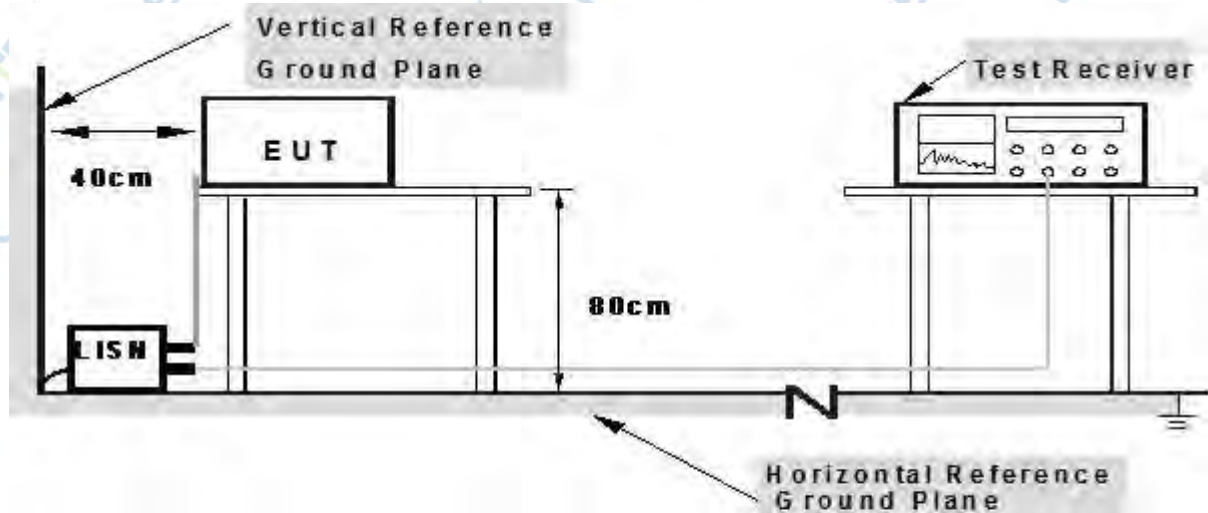
The following table is the setting of the receiver

Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

### 3.1.3 TEST PROCEDURE

- The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- LISN at least 80 cm from nearest part of EUT chassis.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

### 3.1.4 TEST SETUP



**Note: 1.Support units were connected to second LISN.**

**2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes**

### 3.1.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.2 Unless otherwise a special operating condition is specified in the follows during the testing.



## 3.1.6 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	23.1	Relative Humidity:	41
Pressure:	1010hPa	Phase:	N/A
Test Voltage:	N/A	Test Mode:	N/A

Note: The EUT is powered by battery, so this item is not applicable

## 3.2 RADIATED EMISSION MEASUREMENT

### 3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT (Below 1000MHz)

**Table A.2 – Requirements for radiated emissions at frequencies up to 1 GHz for Class A equipment**

Table clause	Frequency range MHz	Measurement		Class A limits dB(μV/m)
		Distance m	Detector type/ bandwidth	OATS/SAC (see Table A.1)
A2.1	30 – 230	10	Quasi Peak / 120 kHz	40
	230 – 1 000			47
A2.2	30 – 230	3		50
	230 – 1 000			57

Apply only A2.1 or A2.2 across the entire frequency range.

**Table A.4 – Requirements for radiated emissions at frequencies up to 1 GHz for Class B equipment**

Table clause	Frequency range MHz	Measurement		Class B limits dB(μV/m)
		Distance m	Detector type/ bandwidth	OATS/SAC (see Table A.1)
A4.1	30 – 230	10	Quasi Peak / 120 kHz	30
	230 – 1 000			37
A4.2	30 – 230	3		40
	230 – 1 000			47

Apply only table clause A4.1 or A4.2 across the entire frequency range.

**Table A.6 – Requirements for radiated emissions from FM receivers**

Table clause	Frequency range MHz	Measurement		Class B limit dB(μV/m)	
		Distance m	Detector type/ bandwidth	Fundamental	Harmonics
				OATS/SAC (see Table A.1)	OATS/SAC (see Table A.1)
A6.1	30 – 230	10	Quasi peak/ 120 kHz	50	42
	230 – 300				42
	300 – 1 000				46
A6.2	30 – 230	3		60	52
	230 – 300				52
	300 – 1 000				56

Apply only A.6.1 or A.6.2 across the entire frequency range.

These relaxed limits apply only to emissions at the fundamental and harmonic frequencies of the local oscillator. Signals at all other frequencies shall be compliant with the limits given in Table A.4.



### 3.2.2 LIMITS OF RADIATED EMISSION MEASUREMENT (Above 1000MHz)

**Table A.3 – Requirements for radiated emissions at frequencies above 1 GHz for Class A equipment**

Table clause	Frequency range MHz	Measurement		Class A limits dB(μV/m)
		Distance m	Detector type/ bandwidth	FSOATS (see Table A.1)
A3.1	1 000 – 3 000	3	Average / 1 MHz	56
	3 000 – 6 000			60
A3.2	1 000 – 3 000		Peak / 1 MHz	76
	3 000 – 6 000			80

Apply A3.1 and A3.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.

**Table A.5 – Requirements for radiated emissions at frequencies above 1 GHz for Class B equipment**

Table clause	Frequency range MHz	Measurement		Class B limits dB(μV/m)
		Distance m	Detector type/ bandwidth	FSOATS (see Table A.1)
A5.1	1 000 – 3 000	3	Average/ 1 MHz	50
	3 000 – 6 000			54
A5.2	1 000 – 3 000		Peak/ 1 MHz	70
	3 000 – 6 000			74

Apply A5.1 and A5.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.

#### Notes:

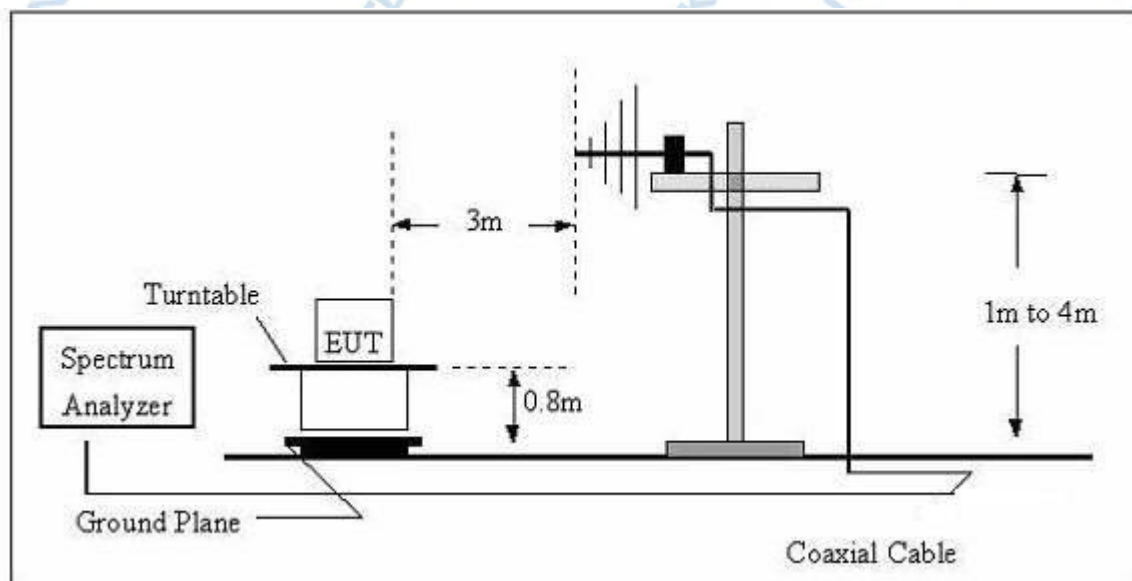
- (1) The limit for radiated test was performed according to as following: CISPR 32.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBμV/m)=20log Emission level (uV/m).

### 3.2.3 TEST PROCEDURE

- The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

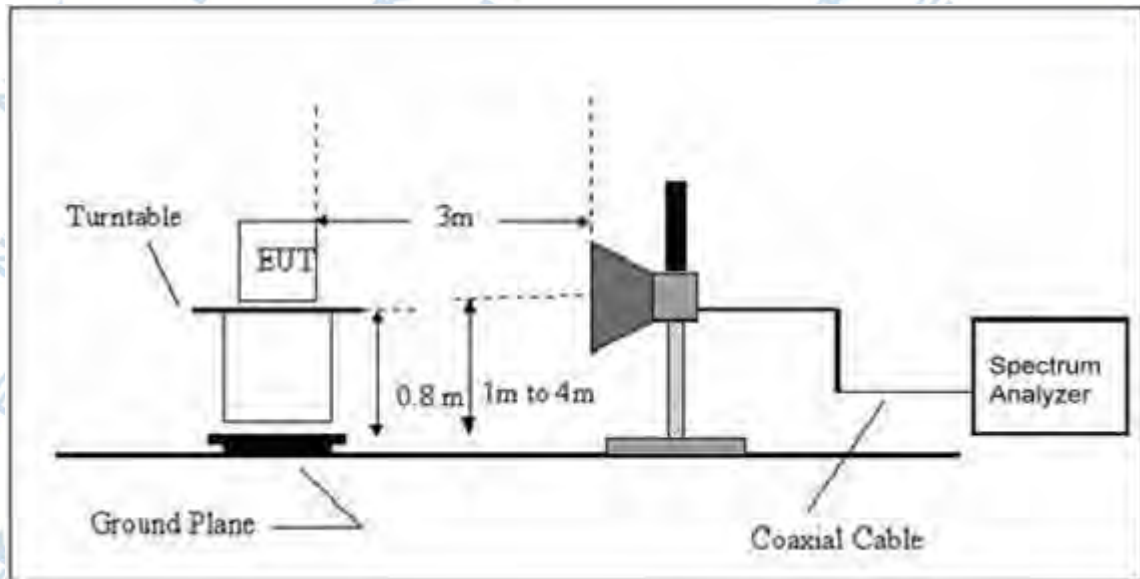
### 3.2.4 TEST SETUP

#### (A) Radiated Emission Test Set-Up Frequency Below 1 GHz





(B) Radiated Emission Test Set-Up Frequency Above 1GHz



3.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.2** Unless otherwise a special operating condition is specified in the follows during the testing.

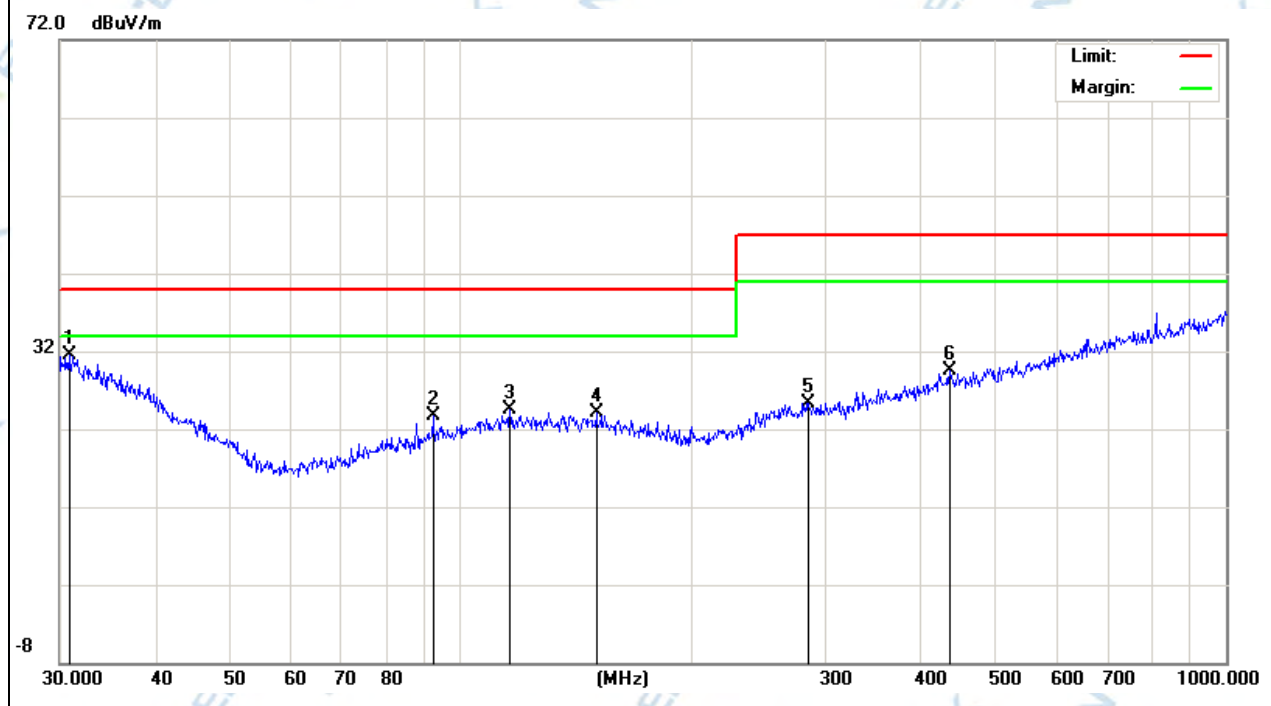
### 3.2.6 TEST RESULTS (30-1000MHz)

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	25.5	Relative Humidity:	53
Pressure:	1010 hPa	Polarization:	Horizontal
Test Power:	DC 3.0V	Test Mode:	Mode 1

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Margin (dB)	Remark
30.8535	5.36	26.12	31.48	40.00	-8.52	QP
92.1388	6.51	17.28	23.79	40.00	-16.21	QP
116.1320	5.86	18.59	24.45	40.00	-15.55	QP
150.5378	5.51	18.64	24.15	40.00	-15.85	QP
284.9766	5.63	19.75	25.38	47.00	-21.62	QP
435.5898	6.19	23.36	29.55	47.00	-17.45	QP

Remark:

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.

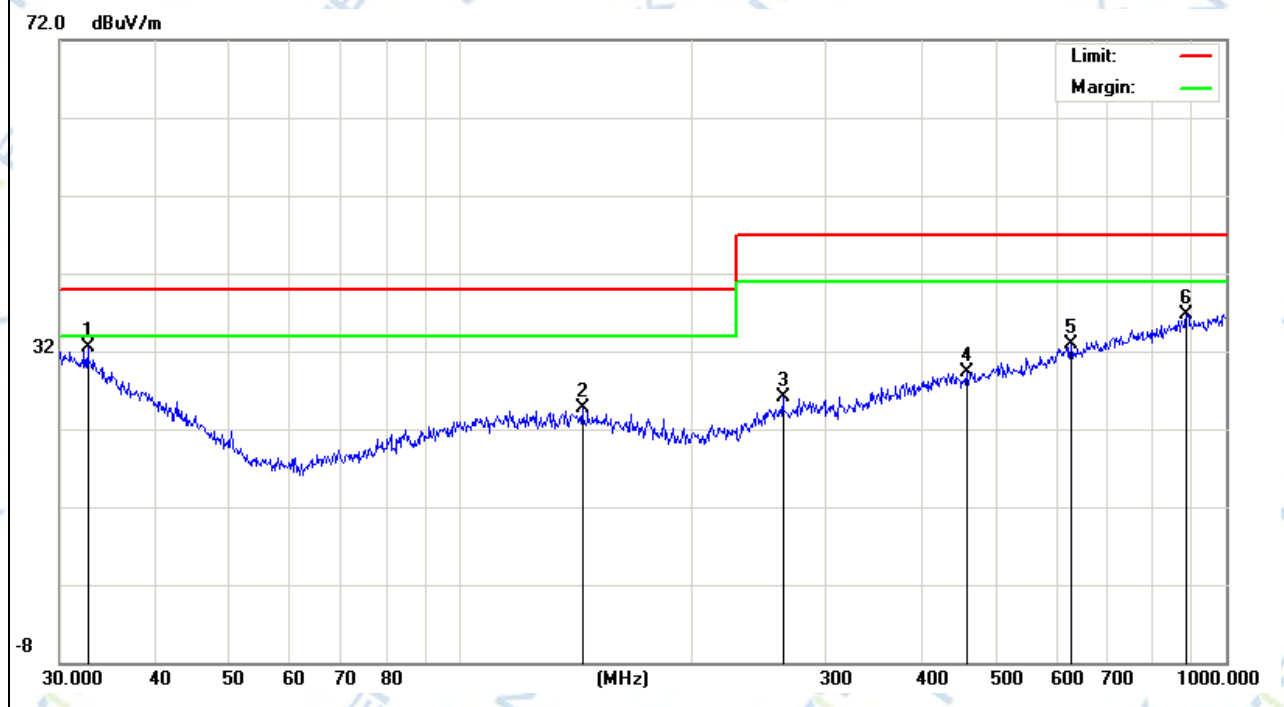


EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	25.5	Relative Humidity:	53
Pressure:	1010hPa	Polarization:	Vertical
Test Power:	DC 3.0V	Test Mode:	Mode 1

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Margin (dB)	Remark
32.6340	7.62	24.81	32.43	40.00	-7.57	QP
144.3348	6.05	18.58	24.63	40.00	-15.37	QP
263.8190	6.76	19.28	26.04	47.00	-20.96	QP
459.1143	5.98	23.35	29.33	47.00	-17.67	QP
627.2738	7.11	25.73	32.84	47.00	-14.16	QP
887.6099	7.36	29.32	36.68	47.00	-10.32	QP

Remark:

1. Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit.



Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.



### 3.2.7 TEST RESULTS(1000-6000MHz)

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	25.2℃	Relative Humidity:	51%
Pressure:	1010hPa	Test Mode:	Mode 1
Test Power:	DC 3.0V		

Polar (H/V)	Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Remark
	(MHz)	(dBμV/m)	(dB)	(dBμV/m)	(dBμV/m)	(dB)	
V	1575.000	40.63	0.03	40.66	70.00	-29.34	peak
V	2437.500	40.29	2.51	42.80	70.00	-27.20	peak
V	2987.500	40.06	4.98	45.04	70.00	-24.96	peak
V	3975.000	37.37	6.63	44.00	74.00	-30.00	peak
V	4825.000	36.07	7.00	43.07	74.00	-30.93	peak
V	5575.000	35.54	7.86	43.40	74.00	-30.60	peak
H	1050.000	40.82	-2.88	37.94	70.00	-32.06	peak
H	1800.000	39.84	0.71	40.55	70.00	-29.45	peak
H	2962.500	40.14	4.83	44.97	70.00	-25.03	peak
H	3975.000	36.59	6.63	43.22	74.00	-30.78	peak
H	4387.500	39.12	6.95	46.07	74.00	-27.93	peak
H	5775.000	35.47	7.84	43.31	74.00	-30.69	peak

**Remark:**

Emission Level= Meter Reading+ Factor, Margin= Emission Level- Limit

Note: The test modes were carried out for all operation modes. The worst test mode for test data was showed in the report.

### 3.3 HARMONICS CURRENT

#### 3.3.1 LIMITS OF HARMONICS CURRENT

Table 1 – Limits for Class A equipment

Harmonic order (n)	Maximum permissible harmonic current (A)
Odd harmonics	
3	2.3
5	1.14
7	0.77
9	0.4
11	0.33
13	0.21
$15 \leq n \leq 39$	$0.15 * (15/n)$
Even harmonics	
2	1.08
4	0.43
6	0.30
$8 \leq n \leq 40$	$0.23 * (8/n)$

Note: Reference standard of the table above: EN61000-3-2.

### 3.3.2 TEST PROCEDURE

a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions.

b. The classification of EUT is according to section 5 of EN 61000-3-2. The EUT is classified as follows:

Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B: Portable tools. Portable tools.; Arc welding equipment which is not professional equipment.

Class C: Lighting equipment.

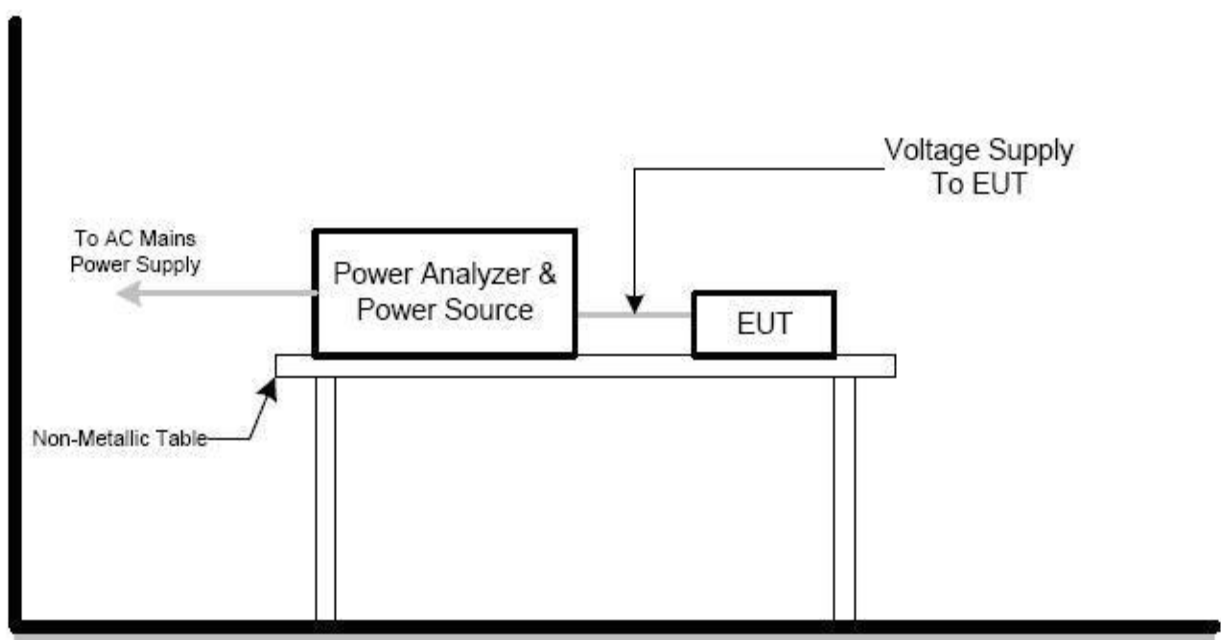
Class D: Equipment having a specified power less than or equal to 600W of the following types: Personal computers and personal computer monitors and television receivers.

c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

### 3.3.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

### 3.3.4 TEST SETUP





## 3.3.5 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1012hPa	Test duration:	150s
Classification:	Class D	Test Power:	N/A
Test Mode:	N/A		

Note: The active input power of the EUT is less than 75 W. No limits apply for equipment with an active input power up to and including 75W.

### 3.4 VOLTAGE FLUCTUATION AND FLICKERS

#### 3.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKERS

Test items	Limits(EN61000-3-3)	Descriptions
$P_{st}$	$\leq 1.0$ , $T_p=10\text{min}$	short-term flicker indicator
$P_{lt}$	$\leq 0.65$ , $T_p=2\text{h}$	long-term flicker indicator
$d_c$	$\leq 3.3\%$	relative steady-state voltage change
$d_{max}$	$\leq 4\%$ (or $6\%$ <sup>Note(1)</sup> , $7\%$ <sup>Note(2)</sup> )	maximum relative voltage change:
$d_{(t)}$	$\leq 3.3\%$ , more than 500ms	relative voltage change characteristic

Note:

1. 6 % for equipment which is:
  - a. switched manually, or
  - b. switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.
2. 7 % for equipment which is
  - a. attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or
  - b. switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

#### 3.4.2 TEST PROCEDURE

##### a. Harmonic Current Test:

Test was performed according to the procedures specified in Sub-clause 6.2 of IEC/EN 61000-3-2 depend on which standard adopted for compliance measurement.

##### b. Fluctuation and Flickers Test:

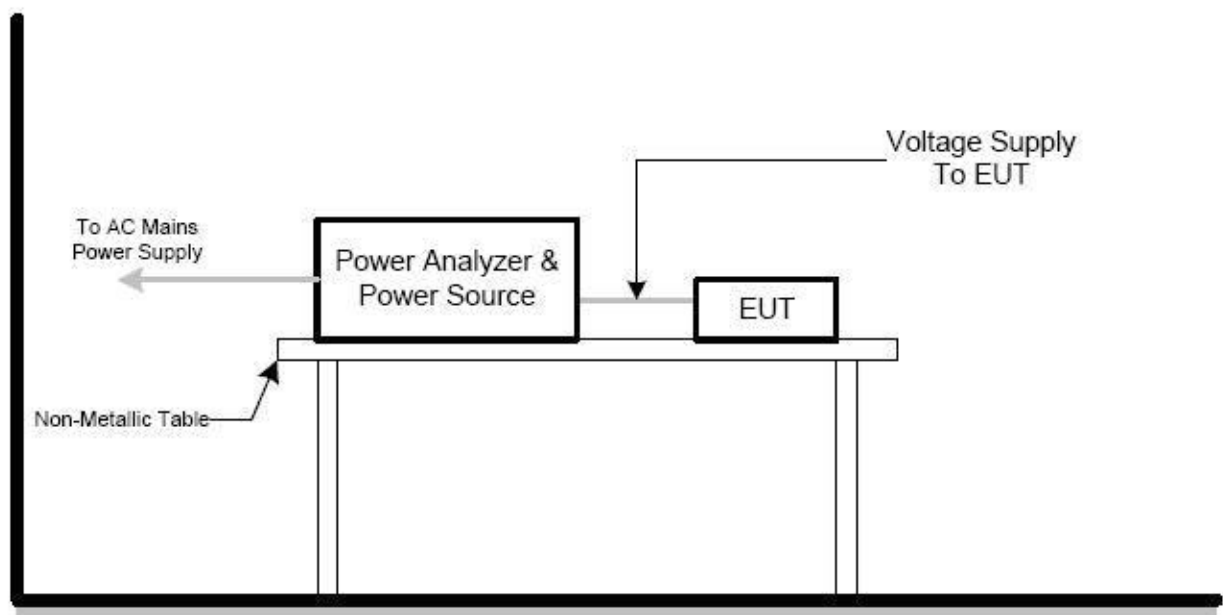
Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 6.0/4.0 of IEC/EN 61000-3-3 depend on which standard adopted for compliance measurement.

c. All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

#### 3.4.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

### 3.4.4 TEST SETUP





## 3.4.5 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1010hPa	Test Power:	N/A
Test Mode:	N/A		

Note: Not applicable

#### 4. EMC IMMUNITY TEST

##### 4.1 GENERAL PERFORMANCE CRITERIA

##### 4.1.1 PERFORMANCE CRITERIA

According to **EN 55035** standard, the general performance criteria as following:

<b>Criterion A</b>	<p>The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.</p> <p>The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.</p>
<b>Criterion B</b>	<p>After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.</p> <p>The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.</p>
<b>Criterion C</b>	<p>Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.</p> <p>Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.</p>



According to **EN 301 489-17** standard, the general performance criteria as following:

Criteria	During the test	After the test
A	<p>Shall operate as intended (see note 1).</p> <p>Shall be no loss of function.</p> <p>Shall be no unintentional transmissions</p>	<p>Shall operate as intended.</p> <p>Shall be no degradation of performance (see note 3).</p> <p>Shall be no loss of function.</p> <p>Shall be no loss of stored data or user programmable functions</p>
B	<p>May show loss of function (one or more).</p> <p>May show degradation of performance (see note 2).</p> <p>Shall be no unintentional transmissions.</p>	<p>Functions shall be self-recoverable.</p> <p>Shall operate as intended after recovering.</p> <p>Shall be no degradation of performance (see note 3).</p> <p>Shall be no loss of stored data or user programmable functions.</p>
C	<p>May be loss of function (one or more)</p>	<p>Functions shall be recoverable by the operator.</p> <p>Shall operate as intended after recovering.</p> <p>Shall be no degradation of performance (see note 3).</p>

NOTE 1: Operate as intended during the test allows a level of degradation not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 3: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.



**PERFORMANCE FOR TT**

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

**PERFORMANCE FOR TR**

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

**PERFORMANCE FOR CT**

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an Acknowledgement (ACK) or Not Acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

**PERFORMANCE FOR CR**

The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

**4.2 GENERAL PERFORMANCE CRITERIA TEST SETUP**

The EUT tested system was configured as the statements of **2.2** Unless otherwise a special operating condition is specified in the follows during the testing.

## 4.3 ESD TESTING

### 4.3.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance	B
Discharge Voltage:	Air Discharge: 2kV/4kV/8kV Contact Discharge: 2kV/4kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: min. 20 times at each test point Contact Discharge: min. 200 times in total
Discharge Mode:	A/C Discharge
Discharge Period:	1 second minimum

### 4.3.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. Indirect application of the discharge:

Vertical Coupling Plane (VCP):

At least 10 single discharges (in the most sensitive polarity) shall be applied to the centre of one vertical edge of the coupling plane. The coupling plane, of dimensions 0,5 m × 0,5 m, is placed parallel to, and positioned at a distance of 0,1 m from, the EUT.

Discharges shall be applied to the coupling plane, with sufficient different positions such that the four faces of the EUT are completely illuminated. One VCP position is considered to illuminate 0,5 m × 0,5 m area of the EUT surface.

Horizontal Coupling Plane (HCP):

Discharge to the HCP shall be made horizontally to the edge of the HCP.

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the centre point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

The discharge electrode shall be in contact with the edge of the HCP before the discharge switch is operated

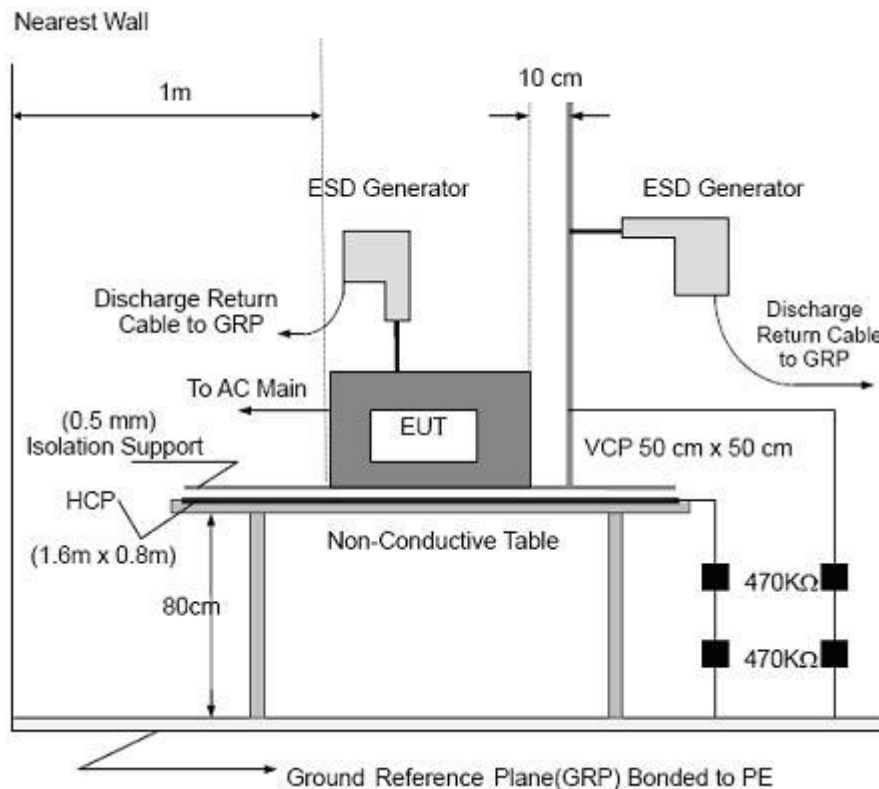
b. Direct application of discharges to the EUT

The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied.

For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.



#### 4.3.3 TEST SETUP



Note:

##### TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

##### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



#### 4.3.4 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1010hPa	Test Power:	DC 3.0V powered by Battery
Test Mode:	Mode 1/2		

Mode	Contact Discharge (Indirect)										Criterion	Result
Test level(kV)	Test Point	2		4		6		8				
Test Location		+	-	+	-	+	-	+	-			
HCP	Front	P	P	P	P					B	Complies	
	Rear	P	P	P	P							
	Left	P	P	P	P							
	Right	P	P	P	P							
VCP	Front	P	P	P	P							
	Rear	P	P	P	P							
	Left	P	P	P	P							
	Right	P	P	P	P							

#### Mode 2

Mode	Air Discharge								Contact Discharge								Observa tion	Criterion	Result
Test level(kV)	2		4		8		15		2		4		6		8				
Test Location	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-			
HCP/VCP									P	P	P	P					TT,TR	B	Complies
Gap	P	P	P	P	P	P													
Screen	P	P	P	P	P	P													

**Mode 1**

Mode	Air Discharge								Contact Discharge								Criterion	Result
Test level(kV)	2		4		8		15		2		4		6		8			
Test Location	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-		
HCP/VCP									P	P	P	P					B	Complies
Gap	P	P	P	P	P	P												
Screen	P	P	P	P	P	P												

Note:

- 1) +/- denotes the Positive/Negative polarity of the output voltage.
- 2) In the table: „P“ represents „PASS“, „F“ represents „FAIL“.

#### 4.4 RS TESTING

##### 4.4.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-3
Required Performance	A
Frequency Range:	According to EN 301 489-1: 80 MHz - 6000 MHz ; According to EN 55035: 80 MHz to 1000 MHz 1800 MHz 2600 MHz 3500 MHz 5000 MHz
Field Strength:	3 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Dwell Time:	at least 3 seconds

##### 4.4.2 TEST PROCEDURE

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

The testing distance from antenna to the EUT was 3 meters.

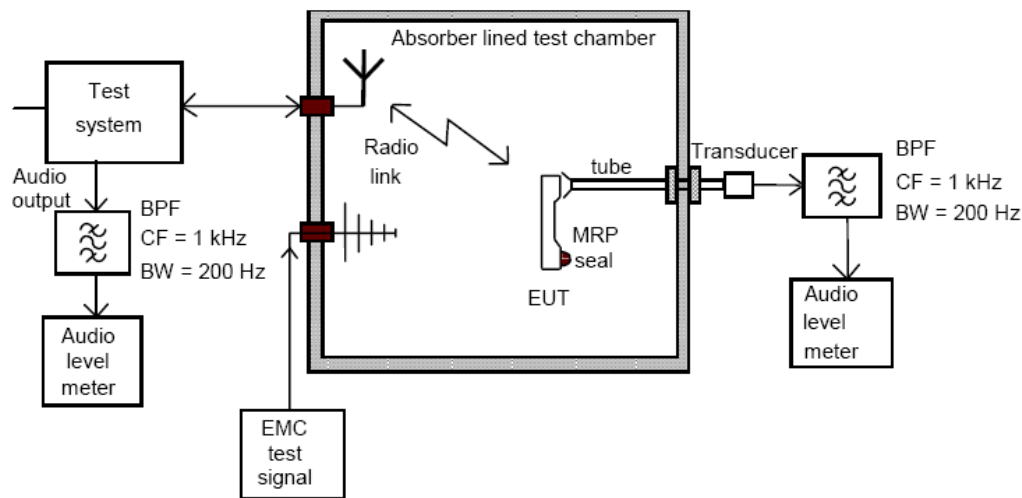
The other condition as following manner:

- The field strength level was 3V/m.
- The frequency range is swept from 80 MHz to 6000 MHz, 1800 MHz, 2600 MHz, 3500 MHz, and 5000MHz with the signal 80%amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed  $1.5 \times 10^{-3}$  decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- Sweep Frequency 900 MHz, with the Duty Cycle:1/8 and Modulation: Pulse 217 Hz(if applicable)
- The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

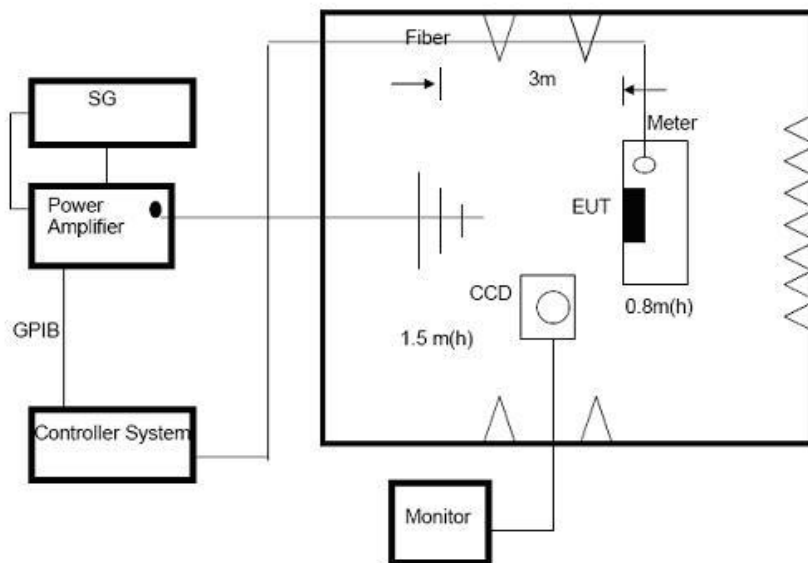


#### 4.4.3 TEST SETUP

☐ Mobile Communication



☒ General Communication



#### Note:

For the actual test configuration, please refer to the related Item –EUT Test Photos.

#### TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### 4.4.4 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	53%
Pressure:	1010hPa	Test Power:	DC 3.0V powered by Battery
Test Mode:	Mode 1/2		

#### TEST RESULT

##### Mode 2

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Observation	Perform. Criteria	Results
80~1000	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	<b>CT,CR</b>	<b>A</b>	<b>P</b>
1000~6000			Rear			
1800			Left			
2600			Right			
3500						
5000						

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

Note:

- 1) N/A - denotes test is not applicable in this test report.
- 2) There was not any unintentional transmission in standby mode
- 3) In the table: „P“ represents „PASS“, „F“ represents „FAIL“.

**Mode 1**

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Perform. Criteria	Results
80~1000 1000~6000	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	<b>A</b>	<b>P</b>
			Rear		
			Left		
			Right		

Note: "A" stand for, during test, operate as intended no loss of function, no degradation of performance, no unintentional transmissions and after test, no degradation of performance, no loss of function, no loss of stored data or user programmable functions.

**Note:**

- 1) N/A - denotes test is not applicable in this test report.
- 2) There was not any unintentional transmission in standby mode
- 3) In the table: „P“ represents „PASS“, „F“ represents „FAIL“.



## 4.5 EFT/BURST TESTING

### 4.5.1 TEST SPECIFICATION

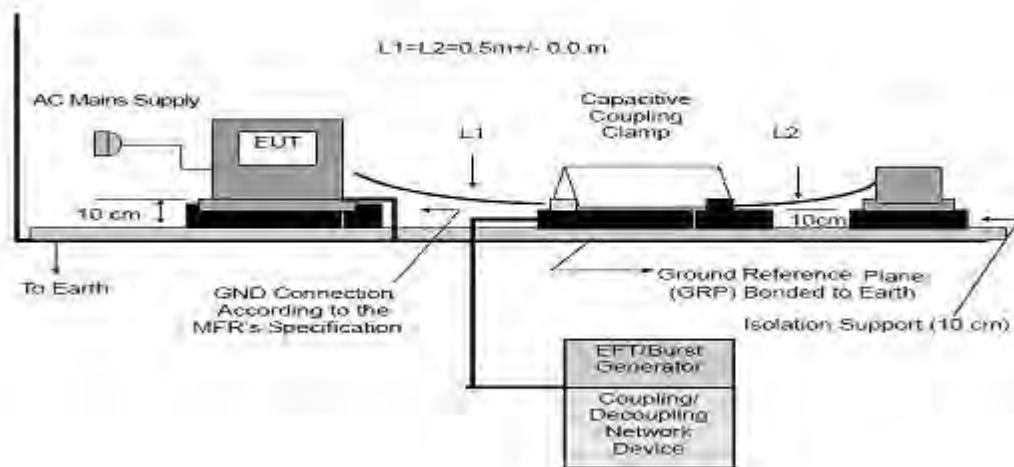
Basic Standard:	IEC/EN 61000-4-4
Required Performance	B
Test Voltage:	Power Line: 1 kV DC/Signal/ wired network Line: 0.5 KV
Polarity:	Positive & Negative
Impulse Frequency:	For xDSL wired network ports: 100 kHz For DC/AC ports: 5 kHz
Impulse Wave shape :	5/50 ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	Not less than 1 min.

### 4.5.2 TEST PROCEDURE

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

The other condition as following manner:

- The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- Both positive and negative polarity discharges were applied.
- The duration time of each test sequential was 1 minute
- For the actual test configuration, please refer to the related Item –EUT Test Photos.



**Note:**

## TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table (0.8m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

## FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-4 and its cables were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.

## 4.5.4 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1010hPa	Test Power:	N/A
Test Mode:	N/A		

Note: Not applicable



## 4.6 SURGE TESTING

### 4.6.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-5
Required Performance	B
Wave-Shape:	Combination Wave 1.2/50 us Open Circuit Voltage 8 /20 us Short Circuit Current
Test Voltage:	Power Line:0.5 kV, 1 kV, 2 kV
Surge Input / Output:	L-N, L-PE, N-PE
Generator Source:	2 ohm between networks
Impedance:	12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0 /90/180/270
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

### 4.6.2 TEST PROCEDURE

a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:

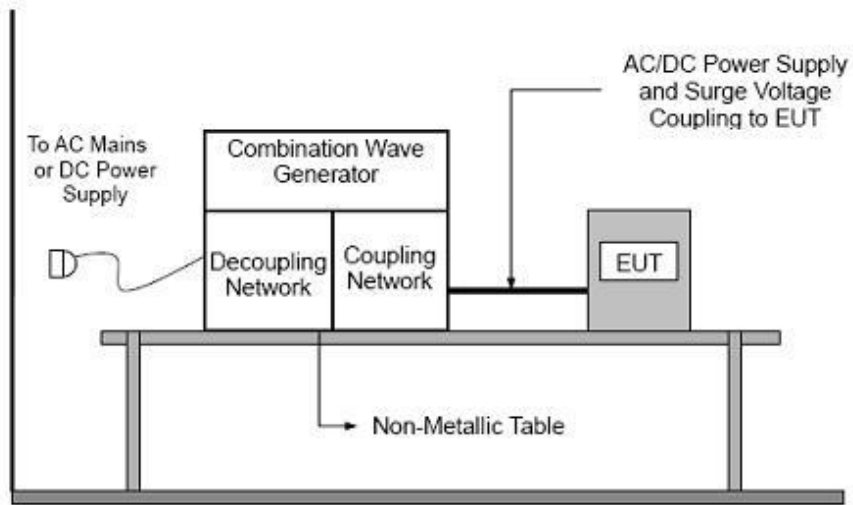
The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

d. For the actual test configuration, please refer to the related Item –EUT Test Photos.

#### 4.6.3 TEST SETUP



## 4.6.4 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1010hPa	Test Power:	N/A
Test Mode:	N/A		

Note: Not applicable



## 4.7 INJECTION CURRENT TESTING

### 4.7.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-6
Required Performance	A
Frequency Range:	0.15 MHz - 80 MHz
Field Strength:	3 Vr.m.s.
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Dwell Time:	at least 3 seconds

### 4.7.2 TEST PROCEDURE

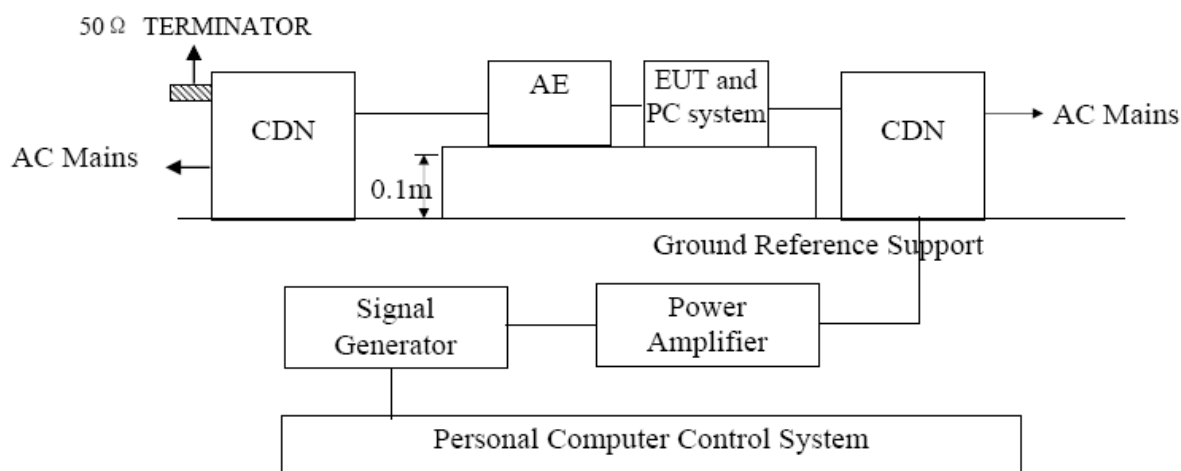
The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

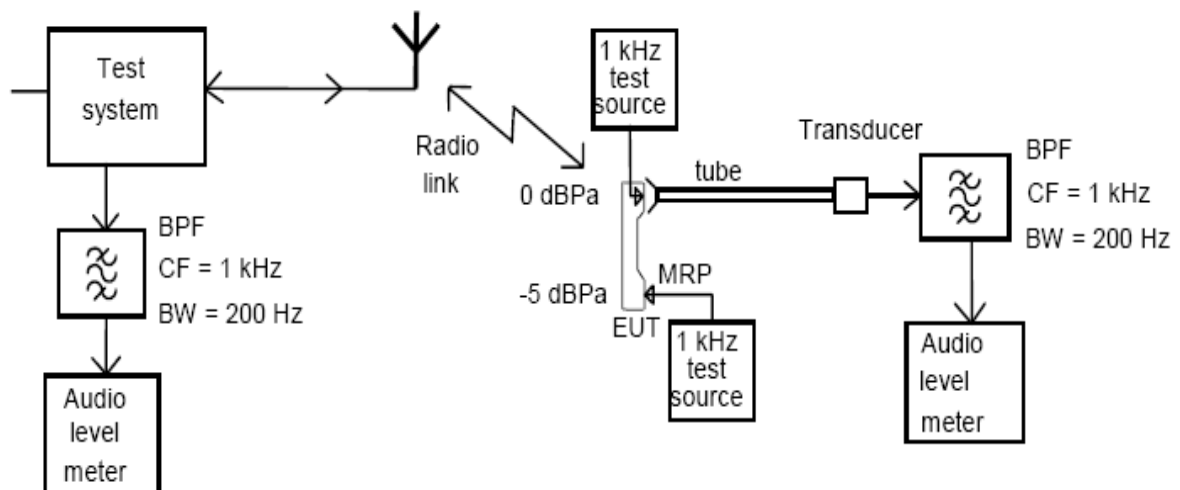
The other condition as following manner:

- The field strength level was 3V.
- The frequency range is swept from 150 KHz to 80 MHz, with the signal 80%amplitude modulated with a 1kHz sine wave. The rate of sweep did not exceed  $1.5 \times 10^{-3}$  decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

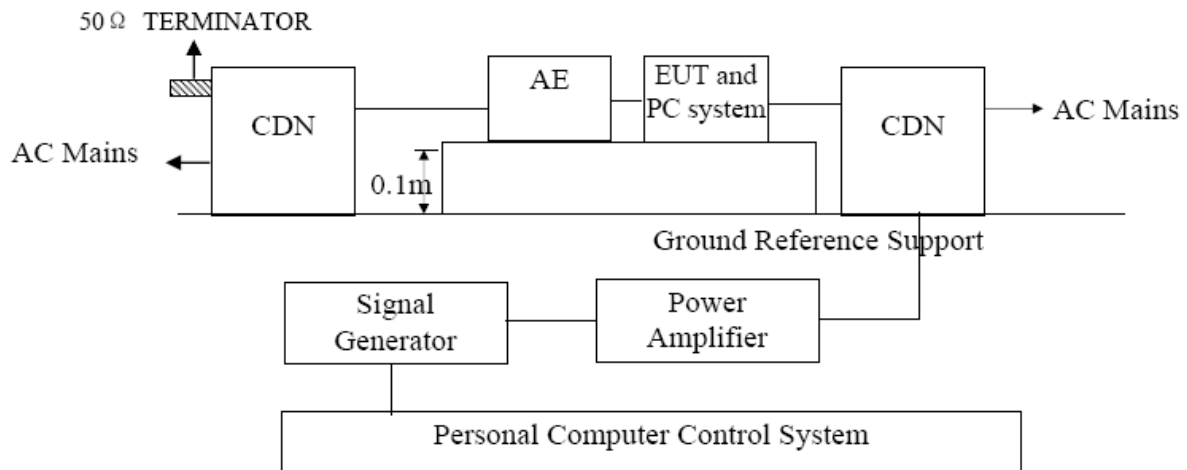
### 4.7.3 TEST SETUP

☐ Mobile Communication





☒ General Communication



For the actual test configuration, please refer to the related Item –EUT Test Photos.

NOTE:

#### FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

## 4.7.4 TEST RESULTS

EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1010hPa	Test Power:	N/A
Test Mode:	N/A		

Note: Not applicable



## 4.8 VOLTAGE INTERRUPTION/DIPS TESTING

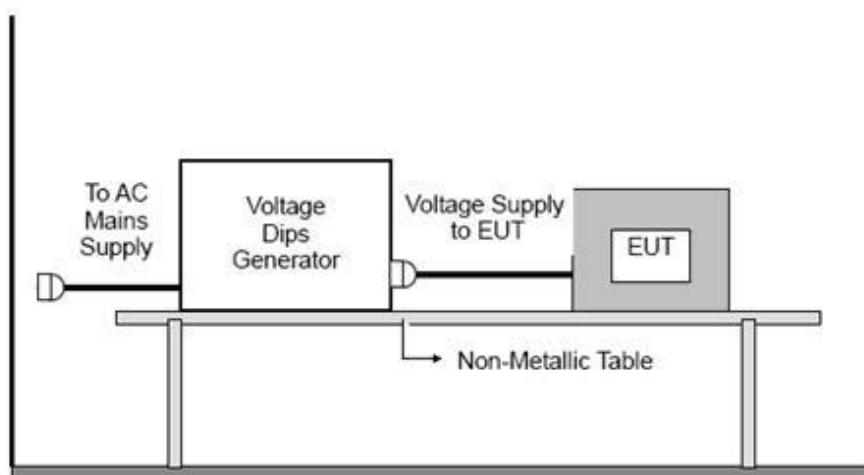
### 4.8.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-11
Required Performance	100% reduction, 0.5 Cycle 100% reduction, 1.0 Cycle 30% reduction, 25 Cycles 30% reduction, 0.5 Cycle
Voltage Interruptions:	100% reduction, 250 Cycles
Test Duration Time:	Minimum three test events in sequence
Interval between Event:	Minimum ten seconds
Phase Angle:	0°/45°/90°/135°/180°/225°/270°/315°/360°
Test Cycle:	3 times

### 4.8.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

### 4.8.3 TEST SETUP



For the actual test configuration, please refer to the related Item –EUT Test Photos.

## 4.8.4 TEST RESULTS

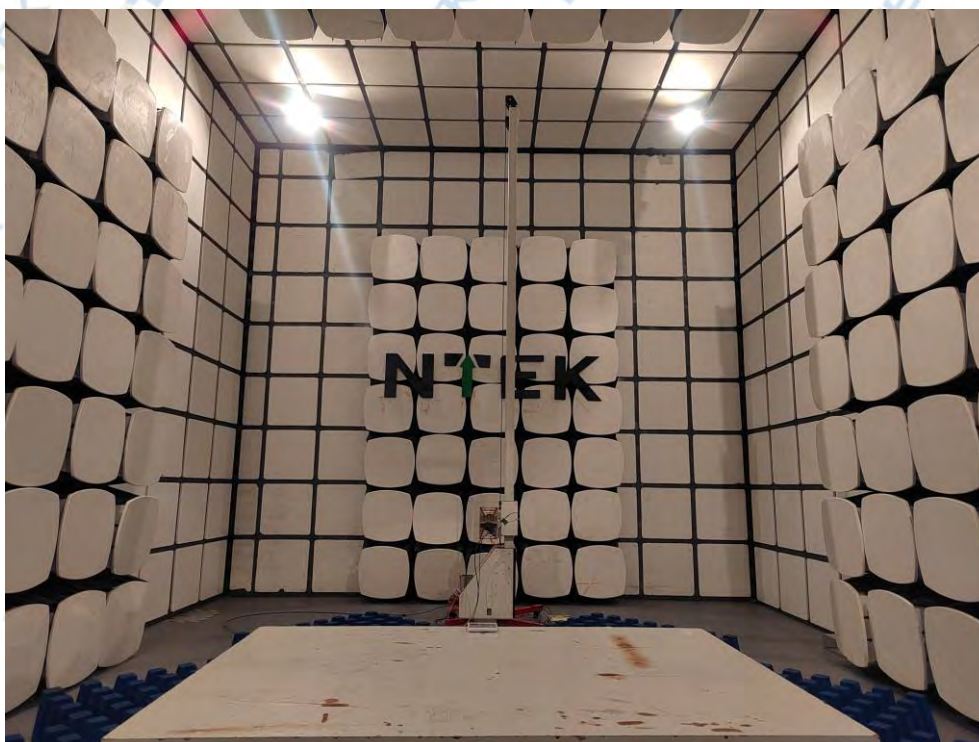
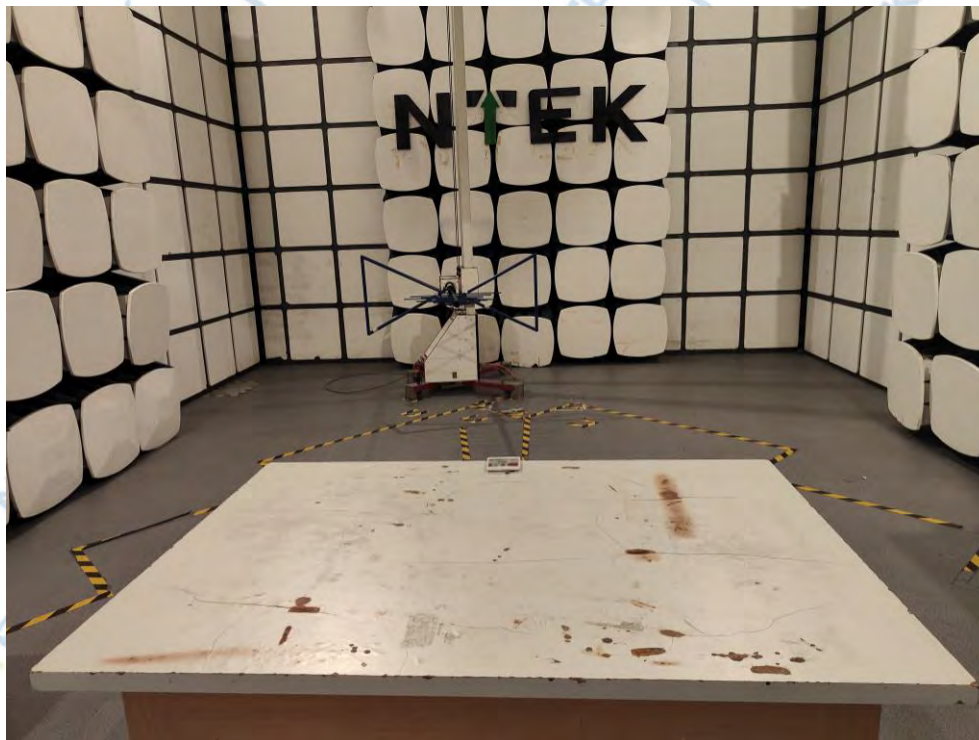
EUT:	Electronic Shelf Label	Model Name:	MTag42R
Temperature:	24℃	Relative Humidity:	52%
Pressure:	1010hPa	Test Power:	N/A
Test Mode:	N/A		

Note: Not applicable



## 5. EUT TEST PHOTO

**Radiated Measurement Photo**



END OF REPORT